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re Statement Int	Applicant Hitoshi Takeda et al.		
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			U.S. Pate	ent Documents			
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Foreign Patent Documents or Published Foreign Patent Applications								
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Attorney's Docket No. 17268-004001 Applicant

Application No. 10/797,497

Information Disclosure Statement by Applicant (Use several sheets if necessary)

Hitoshi Takeda et al.

March 10, 2004

Filing Date

Group Art Unit 2821

(37 CFR §1.98(b))

U.S. Patent Documents Publication Examiner Desig. **Document** Filing Date Initial ID Number Date Patentee Class Subclass If Appropriate 09/16/2004 AA 20040179367 Takeda et al. 362 466 EA AB 20040179368 09/16/2004 Takeda et al. 466 362 AC 20040179366 09/16/2004 Takeda et al. 464 362 AD ΑE ΑF AG AH ΑI ΑJ ΑK

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